Notice of References Cited 10/609,436 Examiner Lalita M Hamilton Reexamination KUTH ET AL. Art Unit Page 1 of 1

Application/Control No.

U.S. PATENT DOCUMENTS

C.S. FATER DOCUMENTS									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification				
	Α	US-2002/0147913	10-2002	Lun Yip, William Wai	713/184				
	В	US-							
	С	US-							
	D	US-							
	E	US-							
	F	US-							
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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